TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC7W02F, TC7W02FU, TC7W02FK

## **DUAL 2-INPUT NOR GATE**

The TC7W02 is a high speed C2MOS 2-INPUT NOR GATE fabricated with silicon gate C2MOS technology. It achives the high speed operation similar to equivalent LSTTL while maintaining the C<sup>2</sup>MOS low power

The internal circuit is composed of 3 stages including buffer output, which enables high noise immunity and stable output.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### **FEATURES**

•	High Spee	t	$t_{pd} = 6ns$	(Typ.)	at
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Low Power Dissipation .....  $I_{CC} = 1\mu A$  (Max.) at

 $Ta = 25^{\circ}C$ 

High Noise Immunity .....  $V_{NIH} = V_{NIL}$ 

=  $28\% \text{ V}_{CC}$  (Min.)

Output Drive Capability ...... 10 LSTTL Loads

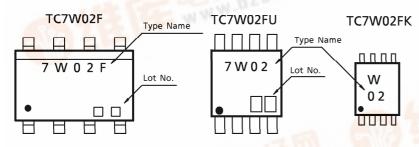
Symmetrical Output Impedance ...  $|I_{OH}| = I_{OL} = 4mA$ 

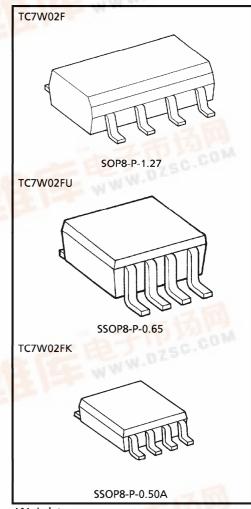
(Min.)

Balanced Propagation Delays ..... t<sub>pLH</sub>≒t<sub>pHL</sub>

Wide Operating Voltage Range ...  $V_{CC(opr)} = 2 \sim 6V$ 

#### **MARKING**





Weight

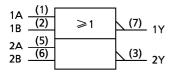
: 0.05g (Typ.) SOP8-P-1.27 SSOP8-P-0.65 : 0.02g (Typ.) SSOP8-P-0.50A : 0.01g (Typ.)



#### **MAXIMUM RATINGS** (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	Vcc	-0.5~7	V
DC Input Voltage	VIN	$-0.5 \sim V_{CC} + 0.5$	V
DC Output Voltage	Vout	$-0.5 \sim V_{CC} + 0.5$	٧
Input Diode Current	ΙΚ	± 20	mA
Output Diode Current	loк	± 20	mA
DC Output Current	IOUT	± 25	mA
DC V <sub>CC</sub> / Ground Current	lcc	± 25	mΑ
Power Dissipation	PD	300	mW
Storage Temperature	T <sub>stg</sub>	- 65~150	°C
Lead Temperature (10s)	ΤL	260	°C

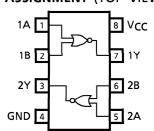
#### **LOGIC DIAGRAM**



#### TRUTH TABLE

А	В	Y
L	L	Н
L	Н	L
Н	L	L
Н	Н	L

## PIN ASSIGNMENT (TOP VIEW)



#### **RECOMMENDED OPERATING CONDITIONS**

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage Range	Vcc	2~6	V
Input Voltage	V <sub>IN</sub>	0~V <sub>CC</sub>	V
Output Voltage	VOUT	0~V <sub>CC</sub>	V
Operating Temperature	T <sub>opr</sub>	- 40~85	°C
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0~1000 (V <sub>CC</sub> = 2.0V) 0~ 500 (V <sub>CC</sub> = 4.5V) 0~ 400 (V <sub>CC</sub> = 6.0V)	ns

#### DC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	TEST CONDITION			Т	a = 25°	C	Ta = -4	ŀ0~85°C	UNIT					
CHARACTERISTIC	3 TIVIBOL			Vcc	MIN.	TYP.	MAX.	MIN.	MAX.						
High Lovel				2.0	1.5	_	_	1.5	_						
High-Level Input Voltage	V <sub>IH</sub>		_	4.5	3.15	_	—	3.15	_	V					
input voitage				6.0	4.2	_	—	4.2	_						
Low-Level				2.0	_	_	0.5	_	0.5						
Input Voltage	V <sub>IL</sub>		_	4.5	—	_	1.35	_	1.35	V					
input voitage				6.0	_	_	1.8		1.8						
				2.0	1.9	2.0	_	1.9	_						
lliah Laval	VOH	V <sub>IN</sub> = V <sub>IL</sub>	$I_{OH} = -20 \mu A$	4.5	4.4	4.5	—	4.4	_						
High-Level				6.0	5.9	6.0	—	5.9	_	V					
Output Voltage			$I_{OH} = -4mA$	4.5	4.18	4.31	_	4.13	_						
			$I_{OH} = -5.2 \text{mA}$	6.0	5.68	5.80	_	5.63	_						
	1 1/01 1			2.0	_	0.0	0.1		0.1						
Lave Lavel			$I_{OL} = 20 \mu A$	4.5	—	0.0	0.1	_	0.1						
Low-Level		$V_{IN} = V_{IH}$		6.0	_	0.0	0.1	_	0.1	V					
Output Voltage		or V <sub>IL</sub>	$I_{OL} = 4mA$	4.5	_	0.17	0.26		0.33						
								$I_{OL} = 5.2 mA$	6.0	_	0.18	0.26	_	0.33	
Input Leakage	IN	V <sub>IN</sub> = V <sub>CC</sub> o	or GND	6.0	_		± 0.1	_	± 1.0						
	Current		-114							$\mu$ A					
Quiescent	lcc	$V_{IN} = V_{CC}$	or GND	6.0	_	_	1.0	_	10.0						
Supply Current		35													

#### AC ELECTRICAL CHARACTERISTICS ( $C_L = 15pF$ , $V_{CC} = 5V$ , Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	Ta = 25°C				
CHARACTERISTIC	3 TIVIBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>	_		4	8	ns	
Propagation Delay Time	t <sub>pLH</sub> t <sub>pHL</sub>	_		6	12	ns	

## AC ELECTRICAL CHARACTERISTICS ( $C_L = 50pF$ , Input $t_r = t_f = 6ns$ )

CHARACTERISTIC	SYMBOL	TEST CONDITION	Ta = $25^{\circ}$ C Ta = $-40^{\circ}$		l0∼85°C	UNIT			
CHARACTERISTIC	STIVIBOL	TEST CONDITION	Vcc	MIN.	TYP.	MAX.	MIN.	MAX.	] [[[]]
Output Transition	t		2.0	_	25	75	_	95	
· ·	t <sub>TLH</sub>	_	4.5	l —	7	15	_	19	ns
Time	t <sub>THL</sub>		6.0	—	6	13	_	16	
Propagation Delay	<b>+</b>		2.0	_	27	75	_	95	
	t <sub>pLH</sub>	_	4.5	l —	9	15	_	19	ns
Time	t <sub>pHL</sub>		6.0	—	8	13	_	16	
Input Capacitance	CIN	_		_	5	10	_	10	
Power Dissipation Capacitance	C <sub>PD</sub>	(Note 1)		_	21	_	_	_	pF

Note 1 : C<sub>PD</sub> is defined as the value of internal equivalent capacitance of IC which is calculated from the operating current consumption without load (refer to Test Circuit).

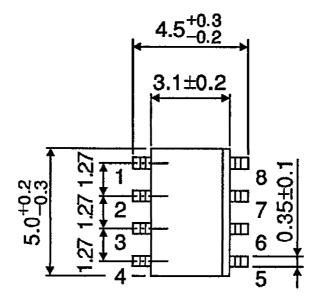
Average operating current can be obtained by the equation hereunder.

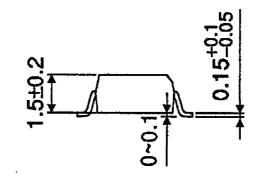
ICC (opr) = CPD·VCC·fIN + ICC / 2 (per gate)

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## PACKAGE DIMENSIONS SOP8-P-1.27

Unit: mm





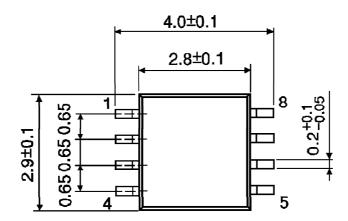
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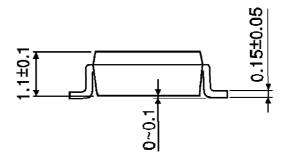
Weight: 0.05g (Typ.)

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## PACKAGE DIMENSIONS SSOP8-P-0.65

Unit: mm



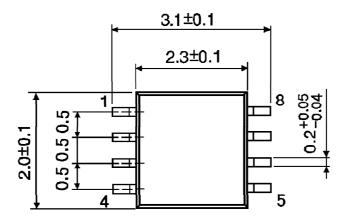


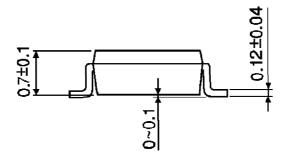
Weight: 0.02g (Typ.)

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## PACKAGE DIMENSIONS SSOP8-P-0.50A

Unit: mm





Weight: 0.01g (Typ.)

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